

**Applications**

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching

$V_{DSS}$	$R_{DS(on) \max}$	$I_D$
<b>500V</b>	<b>0.45Ω</b>	<b>13A</b>

**Benefits**

- Low Gate Charge  $Q_g$  Results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic  $dv/dt$  Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current



**Absolute Maximum Ratings**

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	13	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	8.2	
$I_{DM}$	Pulsed Drain Current ①	52	
$P_D @ T_C = 25^\circ C$	Power Dissipation	180	W
	Linear Derating Factor	1.4	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 30	V
$dv/dt$	Peak Diode Recovery $dv/dt$ ③	3.1	V/ns
$T_J$	Operating Junction and	-55 to + 150	°C
$T_{STG}$	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	

**Typical SMPS Topologies**

- Active Clamped Forward
- Main Switch

Notes ① through ⑤ are on page 8

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# IRFBL12N50A

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Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	500	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.45	$\Omega$	$V_{GS} = 10V, I_D = 7.8A$ ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	25	$\mu A$	$V_{DS} = 500V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 400V, V_{GS} = 0V, T_J = 150^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 30V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -30V$

Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$g_{fs}$	Forward Transconductance	7.5	—	—	S	$V_{DS} = 50V, I_D = 7.8A$
$Q_g$	Total Gate Charge	—	—	64	nC	$I_D = 13A$ $V_{DS} = 400V$ $V_{GS} = 10V$ , See Fig. 6 and 13 ④
$Q_{gs}$	Gate-to-Source Charge	—	—	17		
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	26		
$t_{d(on)}$	Turn-On Delay Time	—	20	—	ns	$V_{DD} = 250V$ $I_D = 13A$ $R_G = 8.8\Omega$ $R_D = 21\Omega$ , See Fig. 10 ④
$t_r$	Rise Time	—	53	—		
$t_{d(off)}$	Turn-Off Delay Time	—	43	—		
$t_f$	Fall Time	—	42	—		
$C_{iss}$	Input Capacitance	—	1900	—	pF	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	—	290	—		$V_{DS} = 25V$
$C_{rss}$	Reverse Transfer Capacitance	—	12	—		$f = 1.0\text{MHz}$ , See Fig. 5
$C_{oss}$	Output Capacitance	—	2615	—		$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	76	—		$V_{GS} = 0V, V_{DS} = 400V, f = 1.0\text{MHz}$
$C_{oss\ eff.}$	Effective Output Capacitance	—	84	—		$V_{GS} = 0V, V_{DS} = 0V$ to $400V$ ⑤

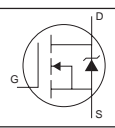
## Avalanche Characteristics

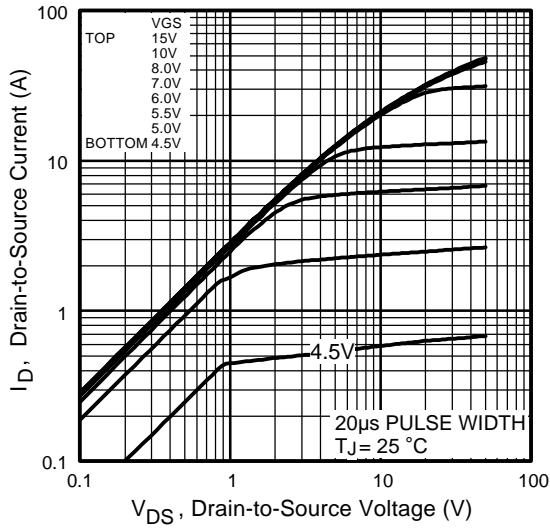
	Parameter	Typ.	Max.	Units
$E_{AS}$	Single Pulse Avalanche Energy②	—	430	mJ
$I_{AR}$	Avalanche Current①	—	13	A
$E_{AR}$	Repetitive Avalanche Energy①	—	18	mJ

## Thermal Resistance

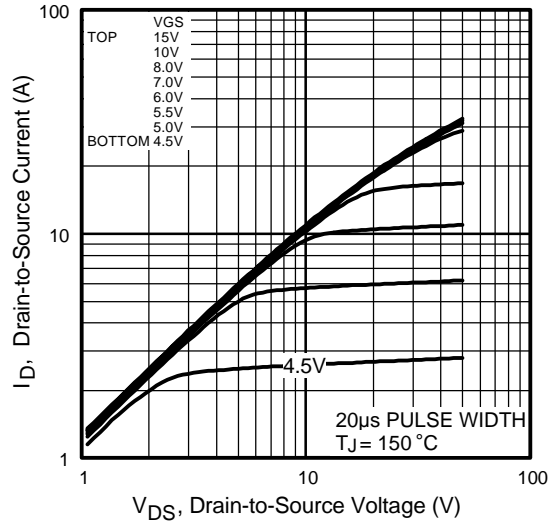
	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	0.70	$^\circ\text{C/W}$
$R_{\theta JA}$	Junction-to-Ambient (PCB Mounted, steady-state)	—	40	

## Diode Characteristics

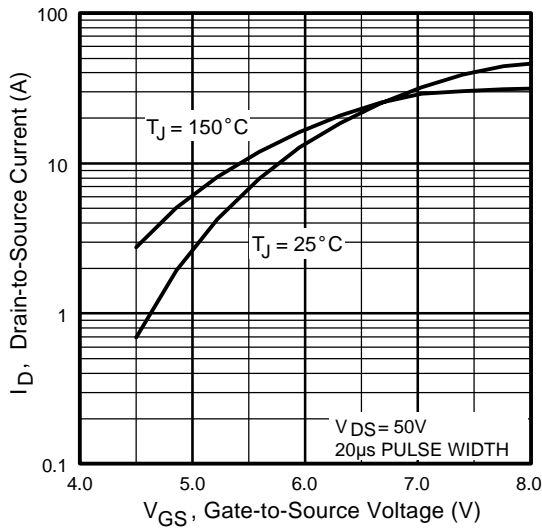
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	13	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	52		
$V_{SD}$	Diode Forward Voltage	—	—	2.0	V	$T_J = 25^\circ\text{C}, I_S = 13A, V_{GS} = 0V$ ④
$t_{rr}$	Reverse Recovery Time	—	540	810	ns	$T_J = 25^\circ\text{C}, I_F = 13A$
$Q_{rr}$	Reverse Recovery Charge	—	4.1	6.1	$\mu\text{C}$	$di/dt = 100A/\mu\text{s}$ ④
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ )				



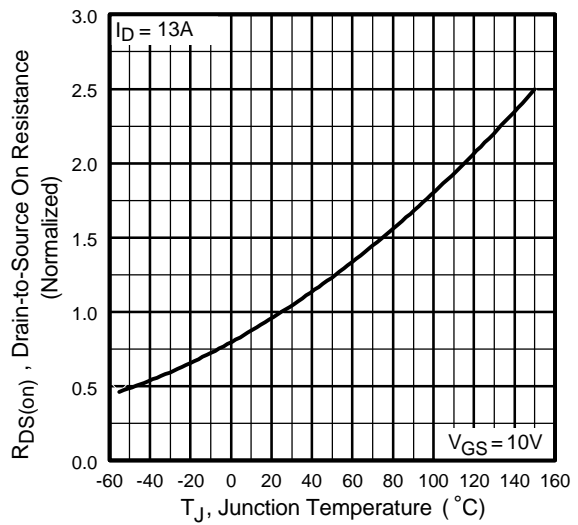
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



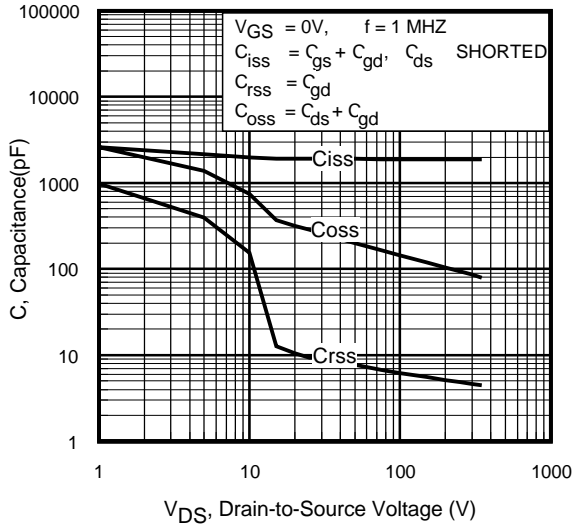
**Fig 3.** Typical Transfer Characteristics



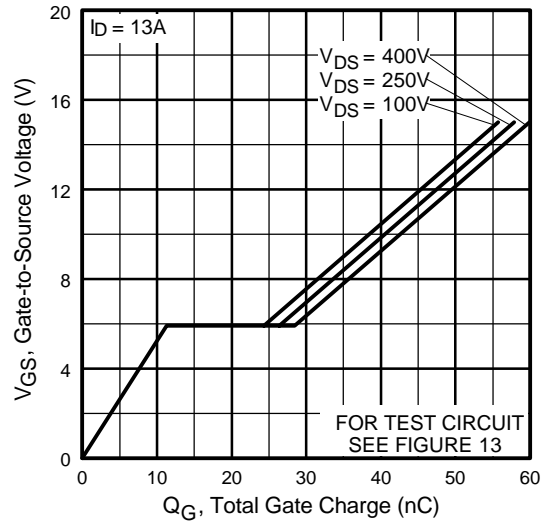
**Fig 4.** Normalized On-Resistance Vs. Temperature

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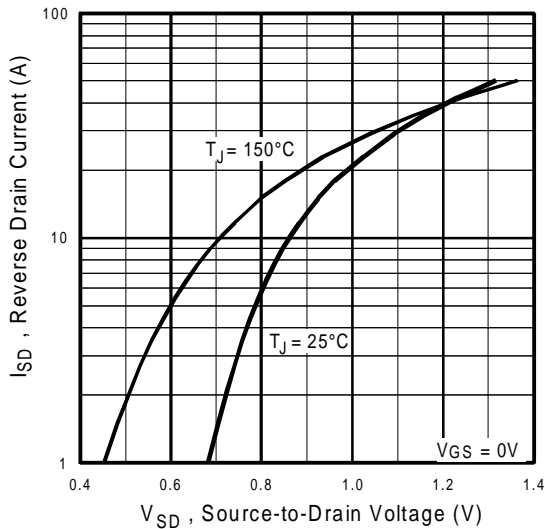
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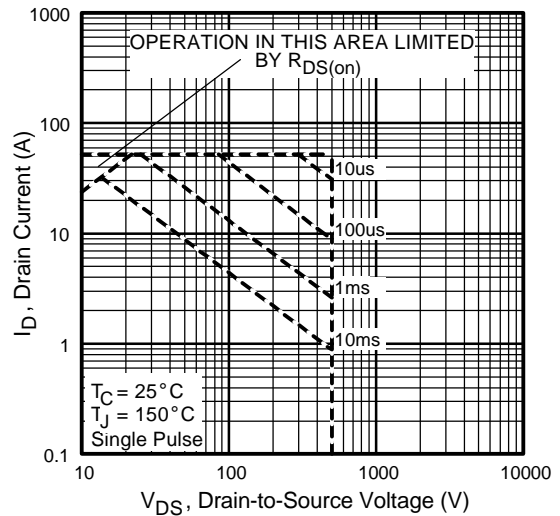
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



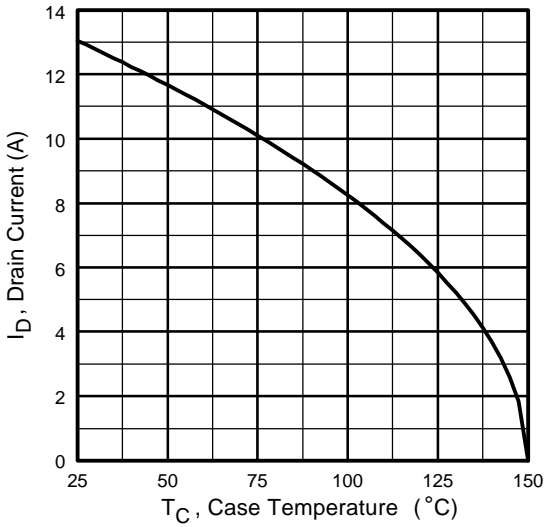
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



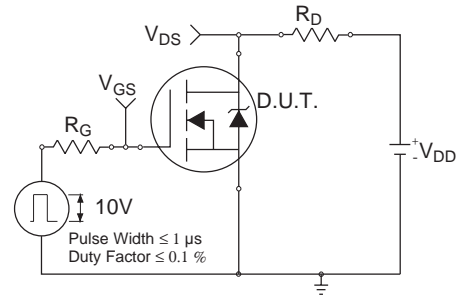
**Fig 7.** Typical Source-Drain Diode Forward Voltage



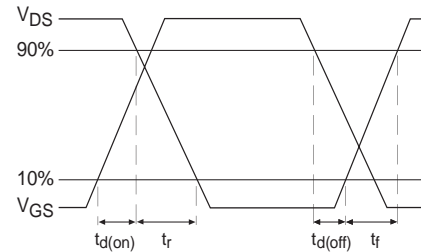
**Fig 8.** Maximum Safe Operating Area



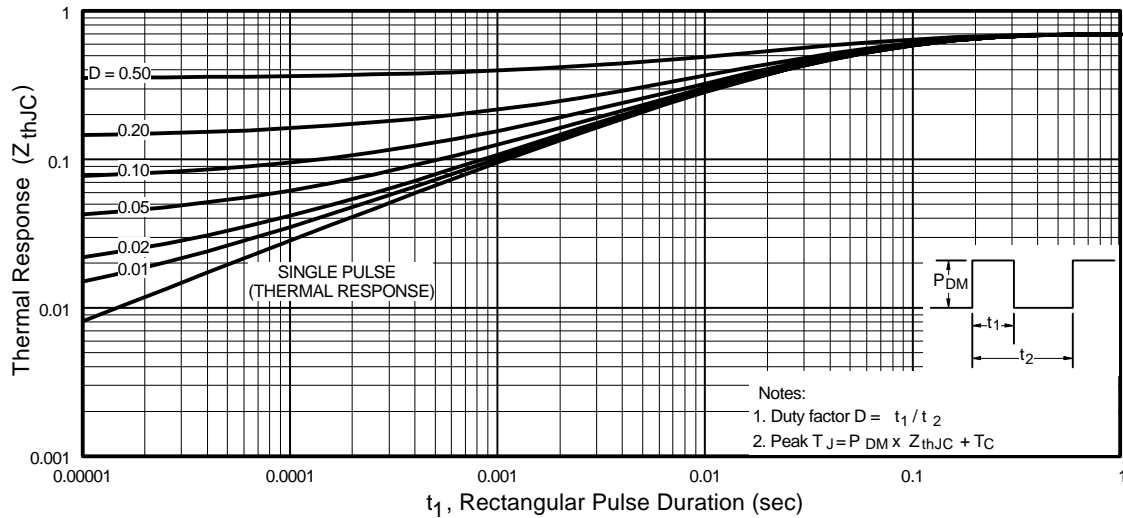
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit

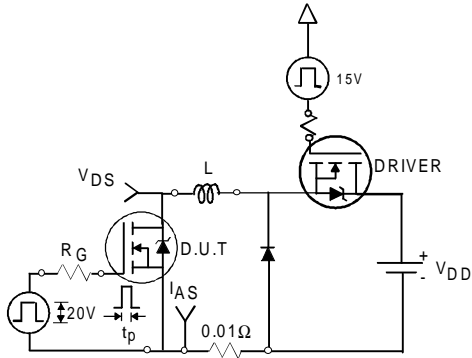


**Fig 10b.** Switching Time Waveforms

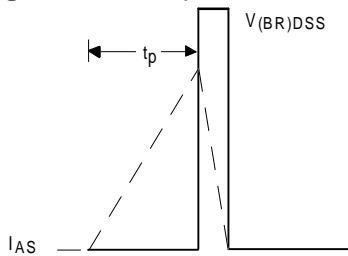


**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

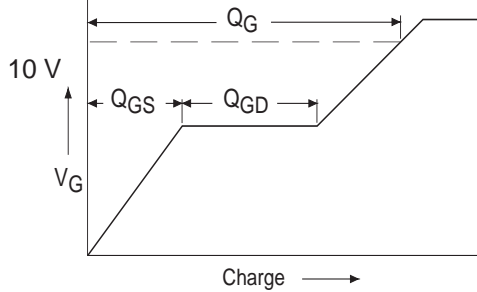
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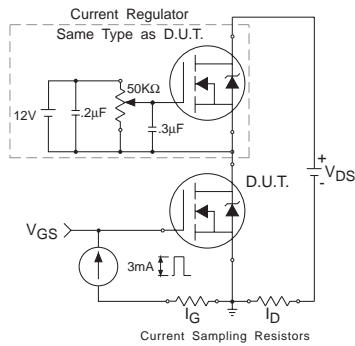
**Fig 12a.** Unclamped Inductive Test Circuit



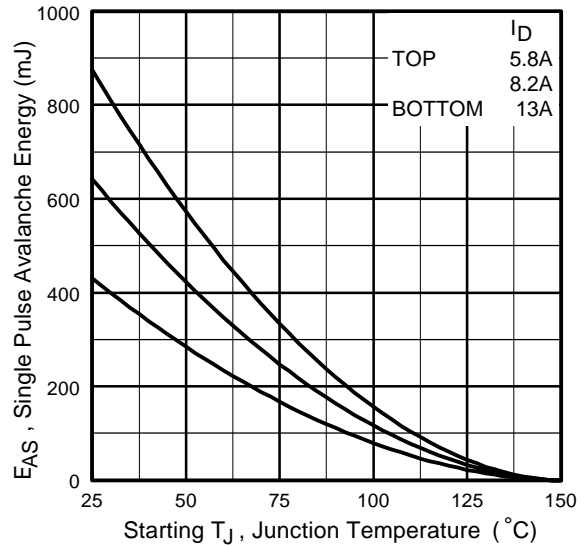
**Fig 12b.** Unclamped Inductive Waveforms



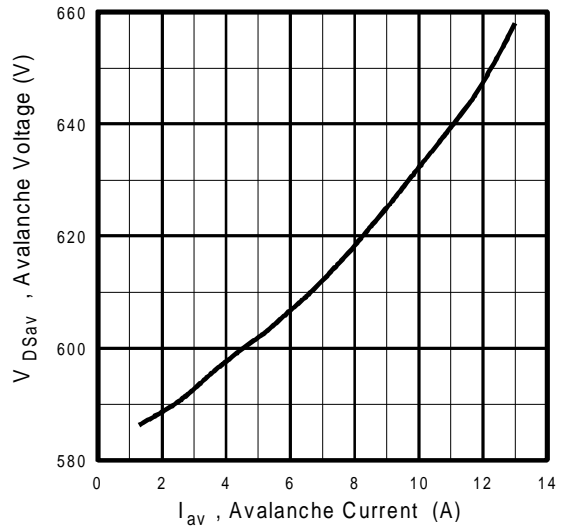
**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

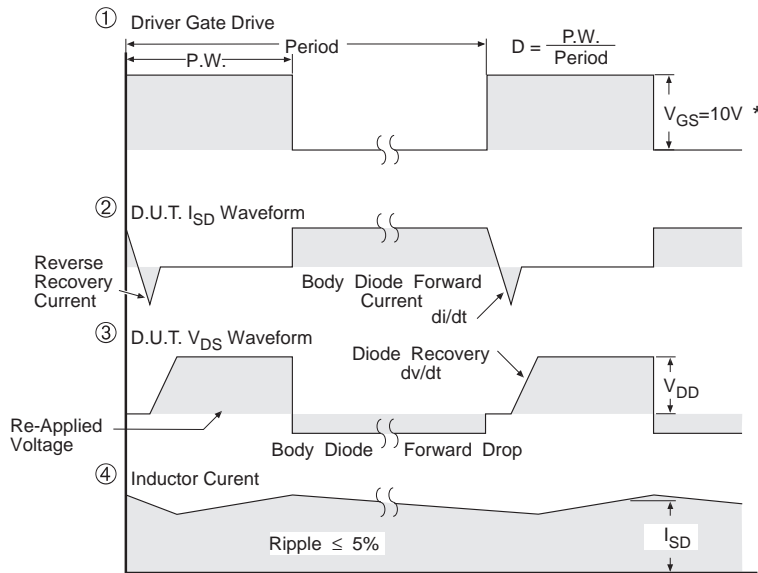
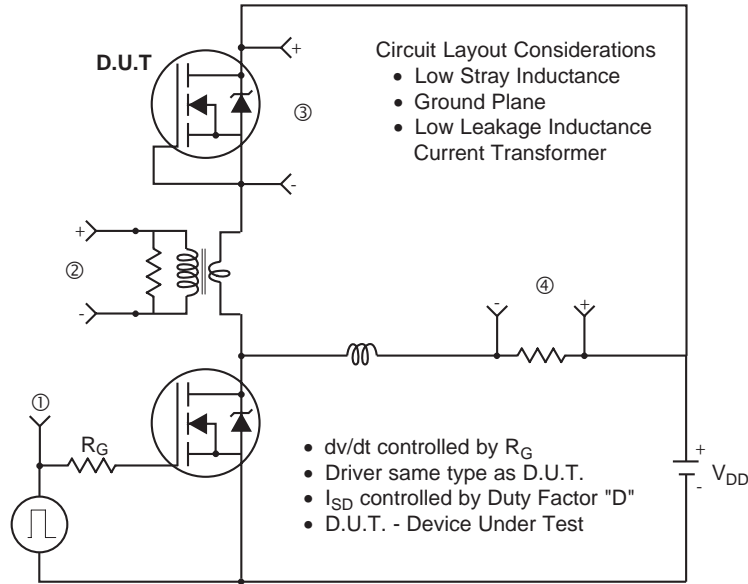


**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 12d.** Typical Drain-to-Source Voltage Vs. Avalanche Current

## Peak Diode Recovery dv/dt Test Circuit



\*  $V_{GS} = 5V$  for Logic Level Devices

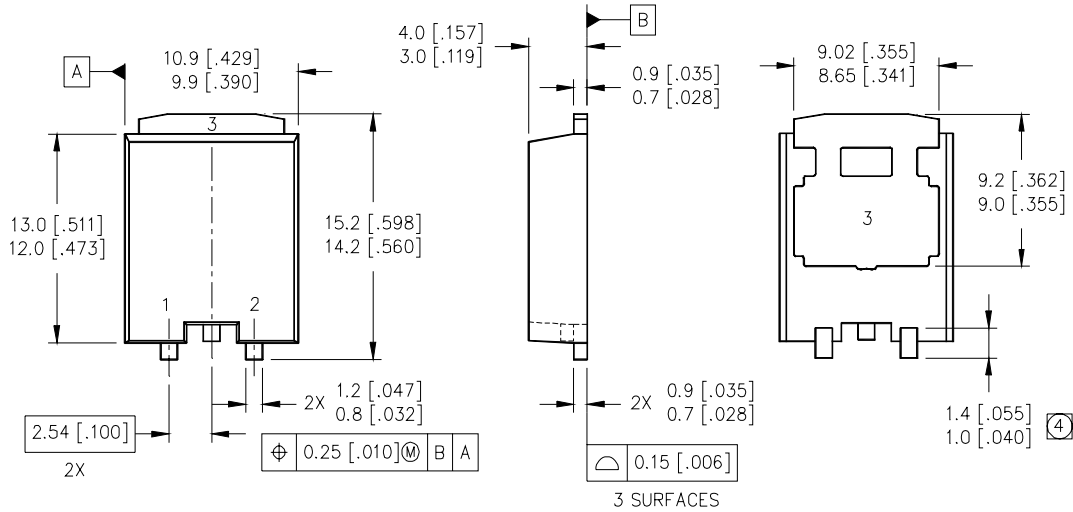
**Fig 14.** For N-Channel HEXFET<sup>®</sup> Power MOSFETs

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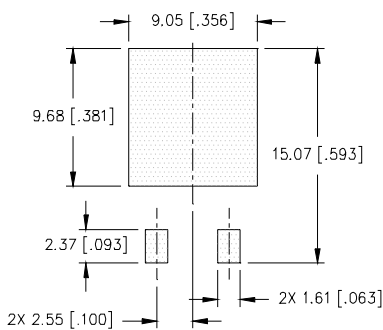
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## Super-D<sup>2</sup>Pak™ Package Outline

Dimensions are shown in millimeters (inches)



### MINIMUM RECOMMENDED FOOTPRINT



### LEAD ASSIGNMENTS

MOSFET	SCHOTTKY / FRED
1 = GATE	1 = ANODE 1
2 = SOURCE	2 = ANODE 2
3 = DRAIN	3 = COMMON CATHODE

### NOTES:

- DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- CONTROLLING DIMENSION: MILLIMETER.
- DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4 DIMENSION IS MEASURED AT FULL LEAD WIDTH.

### Notes:

- Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- Starting  $T_J = 25^\circ\text{C}$ ,  $L = 5.1\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 13\text{A}$ . (See Figure 12)
- Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

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**IR CANADA:** 15 Lincoln Court, Brampton, Ontario L6T3Z2, Tel: (905) 453 2200

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